

Data sheet acquired from Harris Semiconductor SCHS062B – Revised July 2003

# CMOS Binary Rate Multiplier

High-Voltage Types (20-Volt Rating)

rate multiplier that provides an output pulse rate multiplier that provides an output pulse rate that is the clock-input-pulse rate multiplied by 1/16 times the binary input. For example, when the binary input number is 13, there will be 13 output pulses for every 16 input pulses. This device may be used in conjunction with an up/down counter and control logic used to perform arithmetic operations (adds, subtract, divide, raise to a power), solve algebraic and differential equations, generate natural logarithms and trigometric functions, A/D and D/A conversions, and frequency division.

For words of more than 4 bits, CD4089B devices may be cascaded in two different modes: an Add mode and a Multiply mode (see Figs. 14 and 15). In the Add mode some of the gaps left by the more significant unit at the count of 15 are filled in by the less significant units. For example, when two units are cascaded in the Add mode and programmed to 11 and 13, respectively, the more significant unit will have 11 output pulses for every 16 input pulses and the other unit will have 13 output pulses for every 256 input pulses for a total of

 $\frac{11}{16} + \frac{13}{256} = \frac{189}{256}$ 

In the Multiply mode the fraction programmed into the first rate multiplier is multiplied by the fraction programmed into the second multiplier. Thus the output rate will be 11 13 143

16 16 256

#### Features:

- Cascadable in: multiples of 4-bits
- Set to "15" input and "15" detect output
- 100% tested for quiescent current at 20 V
- 5-V, 10-V, and 15-V parametric ratings
- Standardized, symmetrical output characteristics
- Maximum input current of 1 μA at 18 V over full package-temperature range; 100 nA at 18 V and 25°C
- Noise margin (full package-temperature range) =

1 V at V<sub>DD</sub> = 5 V 2 V at V<sub>DD</sub> = 10 V 2.5 V at V<sub>DD</sub> = 15 V

Meets all requirements of JEDEC Tentative Standard No. 13B, "Standard Specifications for Description of 'B' Series CMOS Devices"

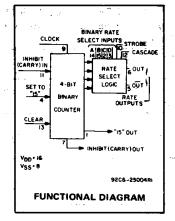
#### Applications:

- Numerical control
- Instrumentation
- Digital filtering
- Frequency synthesis

The CD4089B has an internal synchronous 4-bit counter which, together with one of the four binary input bits, produces pulse trains as shown in Fig. 2.

If more than one binary input bit is high, the resulting pulse train is a combination of the separate pulse trains as shown in Fig. 2.

The CD4089B types are supplied in 16-lead hermetic dual-in-line ceramic packages (F3A suffix), 16-lead dual-in-line plastic packages (E suffix), 16-lead small-outline packages (NSR suffix), and 16-lead thin shrink small-outline packages (PW and PWR suffixes).



CD4089B Types

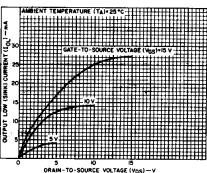


Fig. 1 — Typical output low (sink) current characteristics.

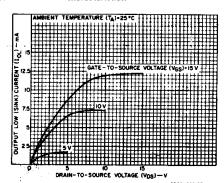


Fig. 2 - Minimum output low (sink) current characteristics.

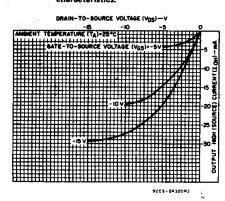


Fig. 3 — Typical output high (source) current characteristics.

MAXIMUM RATINGS, Absolute-Maximum Values: DC SUPPLY-VOLTAGE RANGE, (VDD)

Voltages referenced to VSS Terminal)

-0.5V to +20V INPUT VOLTAGE RANGE, ALL INPUTS

-0.5V to VDD +0.5V DE INPUT CURRENT, ANY ONE INPUT

±10mA

POWER DISSIPATION PER PACKAGE (PD):

For TA = -55°C to +100°C

FOR TA = +100°C to +125°C

Derate Linearity at 12mW/°C to 200mW

DEVICE DISSIPATION PER OUTPUT TRANSISTER

FOR TA = FULL PACKAGE-TEMPERATURE RANGE (All Package Types)

100mW

OPERATING-TEMPERATURE RANGE (Tatg)

-55°C to +125°C

STORAGE TEMPERATURE RANGE (Tatg)

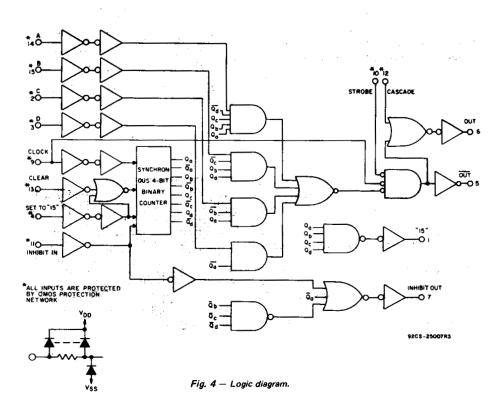
-65°C to +150°C

LEAD TEMPERATURE (DURING SOLDERING):

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RECOMMENDED OPERATING CONDITIONS at  $T_A = 25^{\circ}$ C, Except as Noted. For maximum reliability, nominal operating conditions should be selected so that operation is always within the following ranges:

CHARACTERISTIC		V <sub>DD</sub>	LIÑ	IITS	UNITS
	·	(V)	Min.	Max.	
Supply-Voltage Range (For TA Temperature Range)	= Full Package-		3	18	٧
Set or Clear Pulse Width,	tw	5 10 15	160 90 60	<u> </u>	ns
Clock Pulse Width,	t <sub>W</sub>	5 10 15	330 170 100	- - -	ns
Clock Frequency,	<sup>f</sup> CL	5 10 15	dc	1.2 2.5 3.5	MHz
Clock Rise or Fall Time.	trCL or tfCL	5, 10,15	_	15	μς
Inhibit In Setup Time,	<sup>t</sup> su	5 10 15	100 40 20	_ _ _	ns
Inhibit In Removal Time,	<sup>‡</sup> REM	5 10 15	240 130 110		ns
Set Removal Time,	<sup>†</sup> REM	5 10 15	150 80 50	= * * * * * * * * * * * * * * * * * *	ns
Clear Removal Time,	<sup>t</sup> REM	5 10 15	60 40 30	_ _ _	ns



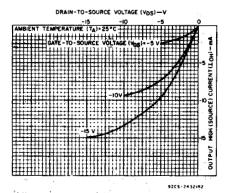


Fig. 5 — Minimum output high (source) current characteristics.

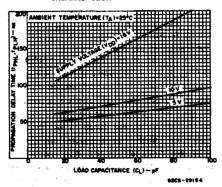


Fig. 6 — Typical propagation delay time as a function of load capacitance (Clock or Strobe to Out).

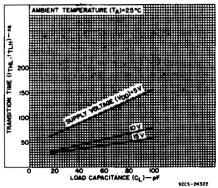


Fig. 7 — Typical transition time as a function of load capacitance.

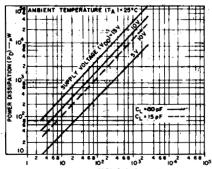


Fig. 8 — Typical dynamic power dissipation as a function of input frequency.

## CD4089B Types

## DYNAMIC ELECTRICAL CHARACTERISTICS at T<sub>A</sub> = 25°C; Input t<sub>r</sub>, t<sub>f</sub> = 20 ns, C<sub>L</sub> = 50 pF, R<sub>L</sub> = 200 k $\Omega$

CHARACTERISTIC	TES					UNITS	
		V <sub>DD</sub>		LIMITS	3	0,4,,,0	
		v	Min.	Тур.	Max.		
Propagation Delay Time, tpHL, tpLH		5	_	110	220		
Clock to Out	j	10	-	55	110		
	<u> </u>	15	<u> </u>	45	90	ns	
		5	-	150	300		
Clock or Strobe to Out		10	-	75	150		
	<del>                                     </del>	15		60	120		
Clock to Inhibit Out	•	5 10	_	360	720		
High Level to Low Level	[	15	_	160 110	320 220	ns	
	<b>——</b>	5		250	500		
Low Level to High Level		10	_	100	200	ns	
i		15	_	75	150		
		5	_	380	760		
Clear to Out		10	-	175	350	ns	
		15		130	260		
8		5	<u> </u>	300	600		
Clock to "9" or "15" Out		10	-	125	250	ns	
		15	_	90	180		
Cascade to Out		5		90	180		
Cascade to Out		10 15	_ '	45 35	90 70	ns	
-		5		160			
Inhibit In to Inhibit Out		10	<u>-</u>	75	320 150		
		15	_	55	110		
:		5	_	330	660	ns	
Set to Out		10	-	150	300		
		15		110	220		
		5	-	100	200		
Transition Time, tTHL, tTLH		10	-	50	100	ns	
		15	_	40	80		
Maniana Charle Frances of		5	1.2	2.4	-		
Maximum Clock Frequency, fCL		10 15	2.5 3.5	5 7	-	MHz	
		_	3.3		220		
Minimum Clock Pulse Width, tw		5 10	_	165 85	330 170	ns	
		15	_ 1	50	100	113	
		5	_	_	15		
Clock Rise or Fall Time, t <sub>rCL</sub> , t <sub>fCL</sub>		10	. —	<u> </u>	15	μs	
<u> </u>		15		_	15		
	*	5	_	80	160		
Minimum Set or Clear Pulse Width, ${}^{\dagger}$ t $_{ m W}$		10	-	45	90	ns	
		15		30	60	. <u> </u>	
		5	- '	50 20	100		
Minimum Inhihit In Satus Time	l			/[]	40	ns	
Minimum Inhibit-In Setup Time, t <sub>SU</sub>		10 15	_			113	
30		15	-	10	20		
Minimum Inhibit-In Setup Time, t <sub>SU</sub> Minimum Inhibit In Removal Time, <sup>t</sup> REM			- - -			ns	

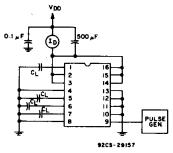


Fig. 9 — Dynamic power dissipation test circuit.

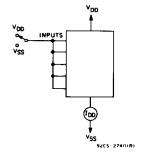


Fig. 10 - Quiescent device current test circuit.

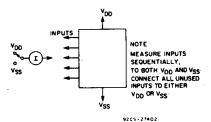


Fig. 11 - Input-current test circuit.

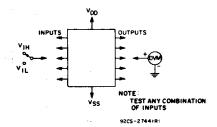
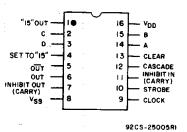


Fig. 12 - Input-voltage test circuit.



TOP VIEW
TERMINAL ASSIGNMENT

## CD4089B Types

DYNAMIC ELECTRICAL CHARACTERISTICS at T\_A = 25°C (cont'd) Input t\_r, t\_f = 20 ns, C\_L = 50 pF, R\_L = 200 k $\Omega$ 

CHARACTERISTIC	TEST CONDITIO	NS						
		VDD		LIMITS				
		V	Min.	Тур.	Max.			
Minimum Set Removal Time, tREM	1	5 10 15		75 40 25	150 80 50	ns		
Minimum Clear Removal Time, tRE	М	5 10 15	- - -	30 20 15	60 40 30	ns		
Input Capacitance, C <sub>IN</sub>	Any Input	-	:- "	5	7.5	pF		

STATIC	FI FCTRICAL	CHARACTERISTICS
31411	ELECINICAL	CHARACTERISTICS

CHARAC- TERISTIC	CON	DITIO	NS	LIN	NITS AT	INDICAT	ED TEM	PERAT		C)	N - T
	V <sub>O</sub>	V <sub>IN</sub>	V <sub>DD</sub>	55	-40	+85	+125	Min.	+25 Typ.	Max.	S
		0.5	5	5	5	150	150		0.04	5	┝
Quiescent Device	_	0,10	10	10	10	300	300		0.04	10	<i>u l</i>
Current,	-	0,15	15	20	20	600	600	-	0.04	20	۳′
IDD Max.	_	0,20	20	100	. 100	3000	3000	-	0.08	100	
0	0.4	0,5	5	0.64	0.61	0.42	0.36	0.51	1	-	Г
Output Low (Sink) Current	0.5	0,10	10	1.6	1.5	1.1	0.9	1.3	2.6	-	
OL Min.	1.5	0,15	15	4.2	4	2.8	2.4	3.4	6.8	-	
0	4.6	0,5	5	-0.64	-0.61	-0.42	-0.36	-0.51	-1	_	m
Output High (Source) Current, IOH Min.	2.5	0,5	5	2	-1.8	-1.3	-1.15	-1.6	+3.2	_	
	9.5	0,10	10	1.6	-1.5	-1.1	-0.9	-1.3	-2.6	-	
	13.5	0,15	15	-4.2	-4	-2.8	- 2.4	-3.4	-6.8	<u> </u>	
Output Voltage:	_	0,5	5		0	.05		0	0.05	Г	
Low-Level,	-	0,10	10		0	.05		0	0.05		
VOL Max.	-	0,15	15		0	.05	-	0	0.05	١,	
Output	-	0,5	-5		4	95		4.95	5	_	1
Voltage:	_	0,10	10	.,	9	.95	,	9.95	10	_	1
High-Level, V <sub>OH</sub> Min.	-	0,15	15		14	.95		14.95	15	-	1
	0.5,4.5		5			1.5		-		1.5	H
Input Low Voltage	1,9	_	10			3		_	<u> </u>	3	1
VIL Max.	1.5,13.5	-	15			4 .		-	1	4	J١
Input High	0.5,4.5	. –	5			3.5		3.5	. –	-	
Voltage,	1,9	-	10			7		7	_	_	
V Min -	1.5,13.5	_	15			11		11		-	L
Input Current		0,18	18.	±0.1 ±0.1 ±1 ±1 - ±10 <sup>-5</sup>				±0.1	μ		

							TRU	JTH TA	BLE				
						INPUT	S				OUTPL	ITS	•
	Input Logic Level Out						utput Log	mber of Pulses or tput Logic Level = Low; H = High)					
D	С	В	A	CLK	INH IN	STR	CAS	CLR	SET	OUT	OUT	INH OUT	"15" OUT
0	0	0	0	16	0	0	0	0	0	L	Н	1	1
0	0	0	1	16	0	0	0	0	0	1	1	1	1
0	0	1	0	16	0	0	0	0	0	2	2	1	1.
0	0	1	1	16	0	0	0	0	0	3	. 3	1.	1
0	1	0	0	16	0	0	0	0	0	4	4	1	1
0	1	0	1	16	0	0	0	0	0	5	5	1	] 1 ]
0	1	1	0	16	0	0	0	0	0	6	6	1	1
0	1	1	1	16	0	0	0	0	0	7	7	1	1
1	0	0	0	16	0	0	0	0	0	8	8	1	1
1	0	0	1	16	0	0	0	0	0	9	9	1	1
1	0	1	0	16	0	. 0	0	0	0	10	10	1	1
1	0	1	1	16	0	0	0	0	0	. 11	11	. 1	1
1	1	0	0	16	0	0	9	0	0	12	12	1	1
1	1	0	1	16	0	0	0	0	0	13	13	1	1
1	1	1	0	16	0	0	0	0	0	14	14	1	1
1	1	1	1	16	0	0	0	0	0	15	15	1	1
x	x	x	х	16	1	0	- O	0	0	†	t	н	†
X	X	х	X	16	0	1	0	0	0	L	н	1	1
X	X	х	X	16	0	0	1	0	0	н	*	1	1
1	х	Х	Х	16	0	0	0	1	0	16	16	Н	L
0	Х	Х	X	16	0	0	0	1	0	L	Н	н	L
X	X	Х	X	16	0	-0	0	X	1	L	н	L	Н {

MOST SIGNIFICAN'	T LEAST SIGNIFIÇANT DIGIT
O C DRM O OUT O CLOCK OUT CASC ST CLEAR S	B ORM © OUT 1 C OWN OUT 1 O INH OUT CLOCK CASC INH IN IST
CLOCK	92 CS - 25008

Fig. 13 – Two CD4089B's cascaded in the "Add" mode with a preset number

of 189 
$$\left(\frac{11}{16} + \frac{13}{256} = \frac{189}{256}\right)$$

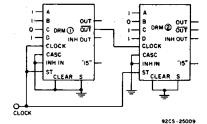


Fig. 14 —Two CD4089B's cascaded in the "Multiply" mode with a preset number

of 143 
$$\left(\frac{11}{16} \times \frac{13}{16} = \frac{143}{256}\right)$$
.

\* Output same as the first 16 lines of this truth table (depending on values of A, B, C, D).

## 

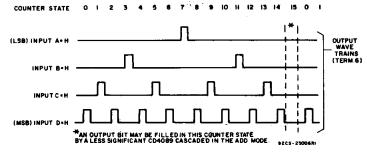
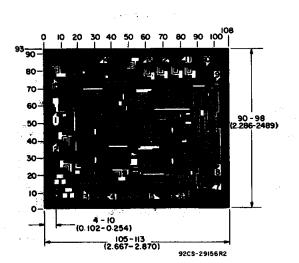


Fig. 15 - Timing diagram.

Dimensions in parentheses are in millimeters and are derived from the basic inch dimensions as indicated. Grid graduations are in mils ( $10^{-3}$  inch).



Dimensions and Pad Layout for CD4089BH

<sup>†</sup> Depends on internal state of counter.





28-Nov-2015

#### **PACKAGING INFORMATION**

Orderable Device	Status	Package Type	Package Drawing		Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
CD4089BE	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD4089BE	Samples
CD4089BEE4	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD4089BE	Samples
CD4089BF3A	NRND	CDIP	J	16	1	TBD	A42	N / A for Pkg Type	-55 to 125	CD4089BF3A	
CD4089BNSR	ACTIVE	so	NS	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD4089B	Samples
CD4089BPWR	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	CM089B	Samples

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between

the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above. **Green (RoHS & no Sb/Br):** TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight

in homogeneous material)

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.



## **PACKAGE OPTION ADDENDUM**

28-Nov-2015

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

#### OTHER QUALIFIED VERSIONS OF CD4089B, CD4089B-MIL:

Military: CD4089B-MIL

NOTE: Qualified Version Definitions:

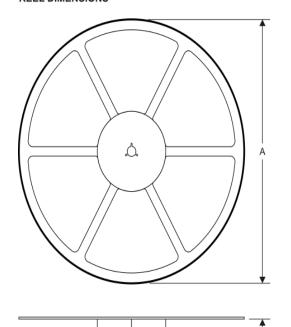
- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications

## PACKAGE MATERIALS INFORMATION

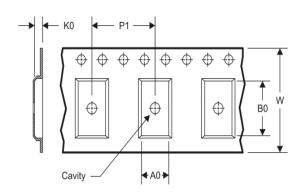
www.ti.com 14-Jul-2012

## TAPE AND REEL INFORMATION

#### REEL DIMENSIONS



#### TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

#### TAPE AND REEL INFORMATION

#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD4089BNSR	SO	NS	16	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1
CD4089BPWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

## **PACKAGE MATERIALS INFORMATION**

www.ti.com 14-Jul-2012



#### \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD4089BNSR	SO	NS	16	2000	367.0	367.0	38.0
CD4089BPWR	TSSOP	PW	16	2000	367.0	367.0	35.0

## 14 LEADS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

## N (R-PDIP-T\*\*)

## PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN

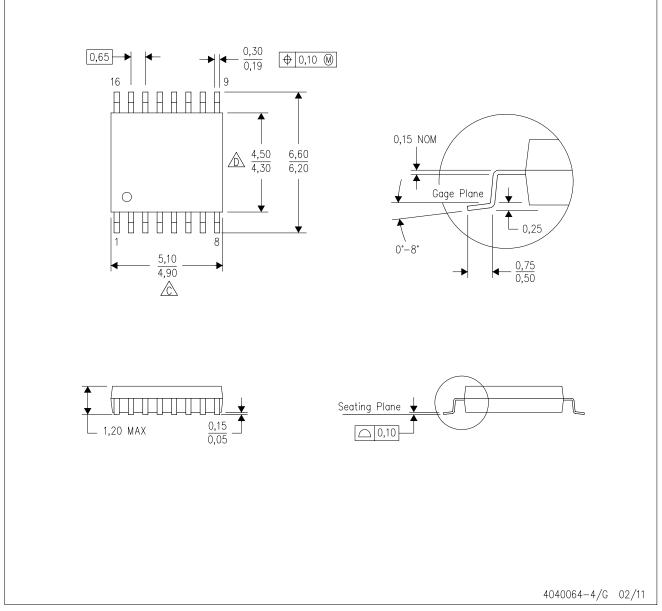


- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.



PW (R-PDSO-G16)

## PLASTIC SMALL OUTLINE

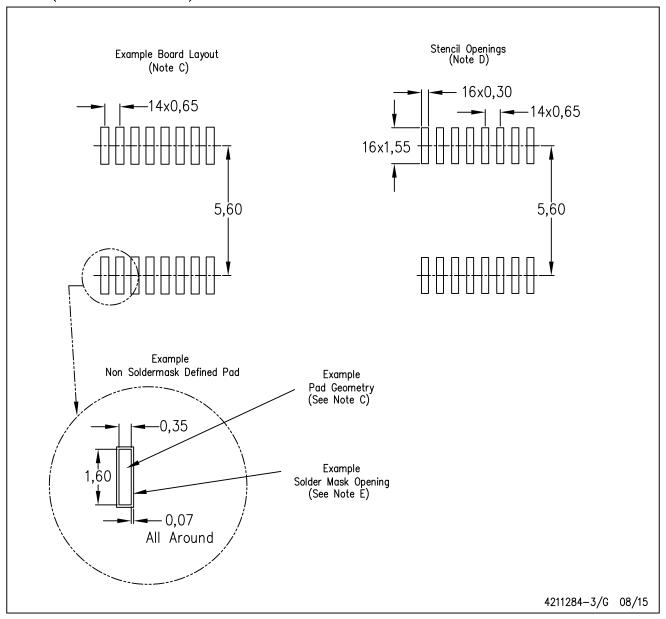


- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
- E. Falls within JEDEC MO-153



## PW (R-PDSO-G16)

## PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



## **MECHANICAL DATA**

## NS (R-PDSO-G\*\*)

## 14-PINS SHOWN

#### PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



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